

Specification & Features

▷ ST2000DLXn

Measurement range	200 Å ~ 35 μm (Depends on film)
Measurement speed	1~2 sec/site
Stage size	150 X 120mm (70 X 50 mm Movement)
Measuring sample size	≤ 4"
Spot size	20 μm Typically
Measurement principle	Reflectometer
Measurement method	Non-contact
Type	Manual
Dimension	190 x 265 x 316 mm
Weight	12Kg
Head	Trinocular Head
Illumination	12v 35w Halogen lamp built-in control device & transformer



Features

Fast Measurement & Easy Operation
Non-contact & Non-destructive
Superb Repeatability & Reproducibility
Windows based user-friendly interface
Print function of each view & data saving
Up to 3 layer measurement

Application

Polymers : PVA, PET, PP, PR & etc Dielectrics : SiO₂, TiO₂, ZrO₂, Si₃N₄ & etc Semiconductors : Poly-Si, GaAs, GaN, InP, ZnS & etc.